

Modern techniques in photoelectron spectroscopy – experiments and data analysis

October 19-22, 2015

Location:

Centrum Szkoleniowo - Konsultacyjne BGŻ S.A.
Fabryczna 1
05-084 Leszno

The invited lecturers are:

Dr. John Åhlund, VG Scienta AB, Uppsala University, Sweden
Photoelectron spectroscopy - instrumentation and applications

Prof. Krystyna Jabłońska, Institute of Physics PAS, Warsaw, Poland
XPS studies of multiphase materials

Prof. Aleksander Jabłoński, Institute of Physical Chemistry PAS, Warsaw, Poland
Parameterization of quantitative applications of XPS

Prof. Jacek Kołodziej, Jagiellonian University, Kraków, Poland
Photoelectron spectroscopy studies of surfaces

Dr. Wojciech Lisowski, Institute of Physical Chemistry PAS, Warsaw, Poland
Sputter depth profiling in XPS

Dr. Laurent Nittler, Institute of Physics PAS, Warsaw, Poland
First experience with the XPS system in IP PAS

Dr. Ewa Przeździecka, Institute of Physics PAS, Warsaw, Poland
ZnO doped by one, two or three acceptors (As, N, Sb)- electronic structure, optical and electrical properties

Prof. Sven Tougaard, [Syddansk Universitet](http://www.syddanskuniversitet.dk), Odense, Denmark
Quantitative XPS of nano-structures with the QUASES software- Practical applications and tutorial examples

Prof. Jacek Szade, University of Silesia, Katowice, Poland
Resonance and standard photoemission studies of thin film systems - determination of valence state and reactions at interfaces

Prof. Wolfgang Werner, Technische Universität, Wien, Austria
Quantitative Interpretation of XPS spectra on nanostructured surfaces with a focus on core-shell nanoparticles

There is no registration fee. The registration can be made by email to:
Anna.Wolska(at)ifpan.edu.pl

Workshop organizing committee:

Prof. Bogdan Kowalski - Workshop chairman
Dr. Marcin Klepka
Dr. Anna Wolska
Maciej Zajęczkowski



October 19, Monday

12:00 - 13:00	registration	
13:00 - 14:30	lunch	
14:30 - 14:45	Prof. Bogdan Kowalski Welcome	15 min
14:45 - 16:15	Dr. John Åhlund Photoelectron spectroscopy - instrumentation and applications	1h 30 min
16:15 - 16:45	coffee break	
16:45 - 17:25	Dr. Laurent Nittler First experience with the XPS system in IP PAS	40 min
17:25 - 18:05	Dr. Ewa Przeździecka ZnO doped by one, two or three acceptors (As, N, Sb) - electronic structure, optical and electrical properties	40 min
18:30 - 19:30	dinner	

October 20, Tuesday

9:30 - 11:00	Prof. Jacek Kołodziej Photoelectron spectroscopy studies of surfaces	1h 30 min
11:00 - 11:30	coffee break	
11:30 - 13:00	Prof. Sven Mosbæk Tougaard Quantitative XPS of nano-structures with the QUASES software- Practical applications and tutorial examples	1h 30 min
13:00 - 14:30	lunch	
14:30 - 16:00	QUASES exercises	1h 30 min
16:00 - 16:30	coffee break	
16:30 - 18:00	QUASES exercises	1h 30 min
18:30 - 19:30	dinner	



October 21, Wednesday

9:30 - 11:00	Prof. Aleksander Jabłoński Parameterization of quantitative applications of XPS	1h 30 min
11:00 - 11:30	coffee break	
11:30 - 13:00	Prof. Wolfgang Werner Quantitative Interpretation of XPS spectra on nanostructured surfaces with a focus on core-shell nanoparticles	1h 30 min
13:00 - 14:30	lunch	
14:30 - 16:00	SESSA exercises	1h 30 min
16:00 - 16:30	coffee break	
16:30 - 18:00	Prof. Jacek Szade Resonance and standard photoemission studies of thin film systems - determination of valence state and reactions at interfaces	1h 30 min
18:30 - 19:30	dinner	

October 22, Thursday

9:30 - 11:00	Dr. Wojciech Lisowski Sputter depth profiling in XPS	1h 30 min
11:00 - 11:20	coffee break	
11:20 - 12:10	Prof. Krystyna Jabłońska XPS studies of multiphase materials	50 min
12:10 - 12:30	Closing remarks	20 min
13:00 - 14:00	lunch	

